Se	arch	Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/827,243	IDE ET AL	
Examiner	Art Unit	
/Yonel Beaulieu/	3661	

SEARCHED			
Class	Subclass	Date	Examiner
701	45-48	10/26/2007	YB
280	728.1		
	734		
	735		
180	282		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
See Int	. Search	10/27/2007	YB

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST+Int.+Fwd/Bwd	10/26/2007	YB
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